

Notice of References Cited	Application/Control No. 10/713,159		Applicant(s)/Patent Under Reexamination HAN ET AL.	
	Examiner Shawntina T. Fuqua		Art Unit 3742	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,189,945	03-1993	Hennick, Donald C.	99/339
*	C	US-3,154,004	10-1964	HUCK ALFRED J	99/390
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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